

Search Notes**Application/Control No.**

10/693,909

Examiner

DANH C. LE

Applicant(s)/Patent under Reexamination

UMESH ET AL.

Art Unit

2683

SEARCHED

Class	Subclass	Date	Examiner
455	562.1	7/29/05	DCL
561			
273			
370	334		
	249		
347	757		
342	372		
	373		

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

Inventor Name Search 7/29/05 DCL
(Check for Double Patent)

EAST Search 7/30/05 DCL
(USP, USPUB)

EAST Search 7/31/05 DCL
(DERWENT, EPUB, JPO)

Lee Nguyen (455)

Han Vuong (455)

Interference Search

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner